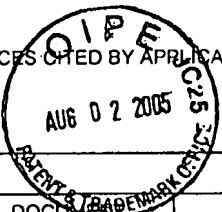
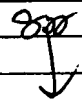
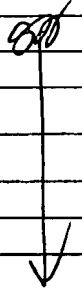
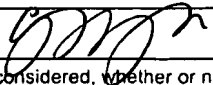


Form PTO 1449 (Modified)		U.S. DEPARTMENT OF COMMERCE PATENT AND TRADEMARK OFFICE		ATTY DOCKET NO. 242342US0DIV		SERIAL NO. 10/730,048	
LIST OF REFERENCES CITED BY APPLICANT				APPLICANT Masahide HOSHINO, et al.			
				FILING DATE December 9, 2003		GROUP	
U.S. PATENT DOCUMENTS							
EXAMINER INITIAL		DOCUMENT NUMBER	DATE	NAME	CLASS	SUB CLASS	FILING DATE IF APPROPRIATE
	AA	5,753,707	05-19-98	HOSHINO et al.			
	AB	5,863,945	01-26-99	MURAYAMA et al.			
	AC	6,685,953	02-03-04	HOSHINO et al.			
	AD						
	AE						
	AF						
	AG						
	AH						
	AI						
	AJ						
	AK						
	AL						
	AM						
	AN						
FOREIGN PATENT DOCUMENTS							
		DOCUMENT NUMBER	DATE	COUNTRY	TRANSLATION YES NO		
	AO	36 17 407	12/04/1986	GERMANY			X
	AP	WO 01/60387	08/23/2001	WIPO			
	AQ	25 15 146	10/21/1976	GERMANY			X
	AR	0 805 192	11/05/1997	EUROPE			
	AS	WO 00/61097	10/19/2000	WIPO (with English Abstract and corr. EP 1 166 766)			X
	AT	1 166 766	01/02/2002	EUROPE			
	AU	55-33448	03/08/1980	JAPAN			X
	AV						
OTHER REFERENCES (Including Author, Title, Date, Pertinent Pages, etc.)							
	AW						
	AX						
	AY						
	AZ					<input type="checkbox"/> Additional References sheet(s) attached	
Examiner					Date Considered		
*Examiner: Initial if reference is considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.							

Form PTO 1449 (Modified)		U.S. DEPARTMENT OF COMMERCE PATENT AND TRADEMARK OFFICE		ATTY DOCKET NO. 242342US0DIV		SERIAL NO. 10/730,048	
LIST OF REFERENCES CITED BY APPLICANT 				APPLICANT Masahide HOSHINO, et al.			
				FILING DATE December 9, 2003		GROUP 1644 1617	
<b>U.S. PATENT DOCUMENTS</b>							
EXAMINER INITIAL		DOCUMENT NUMBER	DATE	NAME	CLASS	SUB CLASS	FILING DATE IF APPROPRIATE
	AA	5,885,955	03/23/1999	Mitsuru UNO, et al.			
	AB	5,656,668	08/12/1997	Keith Robert MOTION, et al.			
	AC	5,643,899	07/01/1997	Peter M. ELIAS, et al.			
	AD						
	AE						
	AF						
	AG						
	AH						
	AI						
	AJ						
	AK						
	AL						
	AM						
	AN						
<b>FOREIGN PATENT DOCUMENTS</b>							
		DOCUMENT NUMBER	DATE	COUNTRY	TRANSLATION YES NO		
	AO	0 390 986 A1	10/10/1990	Europe			
	AP	WO 00/11125	03/02/2000	WIPO			
	AQ	8-311003	11/26/1996	Japan (with English Abstract and Corr. US 5,885,955)		x	
	AR	8-502058	03/05/1996	Japan (with English Abstract and Corr. US 5,656,668)		x	
	AS	10-218849	08/18/1998	Japan (with English Abstract)		x	
	AT	2001-10946	01/16/2001	Japan (with English Abstract)		x	
	AU	7-507326	08/10/1995	Japan (with English Abstract and Corr. US 5,643,899)		x	
	AV						
<b>OTHER REFERENCES (Including Author, Title, Date, Pertinent Pages, etc.)</b>							
	AW						
	AX						
	AY						
	AZ						<input type="checkbox"/> Additional References sheet(s) attached
Examiner 					Date Considered 5/15/07		
<small>*Examiner: Initial if reference is considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.</small>							